

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	09/832,823	LI ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Soon D. Hyun	2616

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
see interference search printout		3/28/2006	HY